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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/532,688	INOUE ET AL.	
Examiner	Art Unit	
John Zhu	2858	

	SEARCHED			
Class	Subclass	Date	Examiner	
324	663	1/26/2006	JZ	
324	664	1/26/2006	JZ	
324	533	1/27/2006	JZ	
324	534	1/27/2006	JZ	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO' (INCLUDING SEARCH)
	DATE	EXMR
324/\$.ccls. keyword search see notes for strategy	1/26/2006	JZ
324/638,642.ccls. subclass search	1/27/2006	JZ
EAST keyword search see notes for strategy	1/27/2006	JZ
Updated IDS search	6/29/2006	JZ
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